Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,797	MOYER ET AL.
Examiner	Art Unit
Daniel Pan	2183

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH STRATEGY)				
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WEST pgp uspat jpoabs epoabs derwent IBM TD IEEE NPL 711/171-173 710/60 712/213 مرز	12/22/2006	DP		